

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/705,477	GEUENS ET AL.	
Examiner	Art Unit	
Bruce H. Hess	1774	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
US P61	Pubs	11-32-05	внн	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Search	11-22-09	внн		
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